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Hamel, J.S.; Tang, Y.T.; Osman, K.

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Kar, G.S.; Maikap, S.; Banerjee, S.K.; Ray, S.K.

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Li, H.; Rein, H.-M.; Kreienkamp, R.; Klein, W.

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Gunnar Malm, B.; Ostling, M.

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Baojun Li; Soo-Jin Chua

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Matsuzawa, A.

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Rogers, J.W.M.; Macedo, J.A.; Plett, C.

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Mizuno, T.; Sugiyama, N.; Tezuka, T.; Takagi, S.

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Yee-Chia Yeo; Subramanian, V.; Kedzierski, J.; Peiqi Xuan; Tsu-Jae King; Bokor Chenming Hu

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Meghelli, M.; Rylyakov, A.V.; Lei Shan

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Aparin, V.; Gazzerro, P.; Jianjun Zhou; Bo Sun; Szabo, S.; Zeisel, E.; Segoria, Ciccarelli, S.; Persico, C.; Narathong, C.; Sridhara, R.

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